Search Notes



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Applicant(s)/Patent Under Reexamination

CHANG ET AL.

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Ehichioya, Fred I

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SEARCHED Class Subclass Date Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
IEEE Xplore	12/16/07	FE	
East (US-PGPub, USPat, EPO, JPO, Derwent).text search only	12/17/07	FE	
East (US-PGPub, USPat, EPO, JPO, Derwent).text search only	6/24/08	FE	
Google.com	6/24/08	FE	

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